


<b>Search Notes</b>  	<b>Application/Control No.</b>  09492300	<b>Applicant(s)/Patent Under Reexamination</b>  AGANO, TOSHITAKA
	<b>Examiner</b>  Nguyen, Jennifer T	<b>Art Unit</b>  2629

SEARCHED			
Class	Subclass	Date	Examiner
345	89,102,211,589,690	3/12/08	JN

SEARCH NOTES		
Search Notes	Date	Examiner
US-PAT, PG-PUB, JPO, EPO, DERWENT, Inventor, Claim interference	3/12/08	JN

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
349	61,65,68-70	3/12/08	JN